

**Search Notes**

Application/Control No.

10/712,119

Examiner

Y. J. Han

Applicant(s)/Patent under  
Reexamination

KOERNER ET AL.

Art Unit

2838

**SEARCHED**

Class	Subclass	Date	Examiner
323	265		
	271		
	273		
320	150		
	152		
	153		
322	28		
	33		
	34	6/05	GH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR